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TEST REPORT

ETSI EN 300 328 V1.7.1 (2006-10)

Report Reference No...... CTL130619922-WR

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Date of issue...... June 21, 2013

Testing Laboratory Name Shenzhen CTL Electromagnetic Technology Co., Ltd.

Address...... Zone B, 4/F, Block 20, Guangqian Industrial Park, Longzhu Road,

Nanshan, Shenzhen 518055 China.

anna!

Applicant's name.....

Address....:

Test specification:

Standard ETSI EN 300 328 V1.7.1: 2006-10

Master TRF...... Dated 2011-01

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Test item description: HEADPODS

Trade Mark:

COMFREE®

Model/Type reference...... PH-4028-BL

Modulation..... FHSS

Ratings...... DC 5V from USB/ DC 3.7V from battery

Operating Frequency Range...... 2402~2480MHz

Channel Number 79

Channel Space 1MHz

Maximum Transmitter Power(EIRP).: 1.68 dBm

Result..... Positive

TEST REPORT

Report No.: CTL130619922-WR

Test Report No. :	CTI 130619922-WP	FL130619922-WR June 21, 2013
rest Report No	G1E130019922-WIK	Date of issue

HEADPODS Equipment under Test

Model /Type PH-4028-BL

Listed Models

Applicant

Address

Manufacturer

Address

Test Result according to the standards on page 4:	Positive 2	
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The test report merely corresponds to the test sample. It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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1. TEST STANDARDS

The tests were performed according to following standards:

ETSI EN 300 328 V1.7.1 (2006-10)— Electromagnetic compatibility and Radio spectrum Matters(ERM); Wideband transmission systems; Data transmission equipment operating in the 2,4 GHz ISM band and using wide band modulation techniques; Harmonized EN covering essential requirements under article 3.2 of the R&TTE Directive



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2. SUMMARY

2.1. General Remarks

Date of receipt of test sample : June 19, 2013

Testing commenced on : June 19, 2013

Testing concluded on : June 21, 2013

2.2. Equipment Under Test

Power supply system utilised

Power supply voltage : o 230V / 50 Hz o 115V / 60Hz o 12 V DC o 24 V DC

Other (specified in blank below)

2.3. Short description of the Equipment under Test (EUT)

The device is a/an HEADPODS, work frequency at 2.4~2.4835GHz, support Bluetooth.

For more details, refer to the user's manual of the EUT.

Serial number: Prototype

2.4. EUT operation mode

The EUT has been tested under typical operating condition. No software used to control the EUT for staying in transmitting and receiving mode for testing.

2.5. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

o - supplied by the manufacturer

• - supplied by the lab

Notebook
 Manufacturer: HP

Model No.: 4-1007TX

2.6. Performance level

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test relative to a performance criteria defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product. Examples of functions defined by the manufacturer to be evaluated during testing include, but are not limited to, the following:

- essential operational modes and states;
- tests of all peripheral access(hard disks, floppy disks, printers, keyboard, mouse, etc.);
- quality of software execution
- quality of data display and transmission
- quality of speech transmission

Definition related to the performance level:

- based on the used product standard
- o based on the declaration of the manufacturer, requestor or purchaser



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3. TEST ENVIRONMENT

3.1. Address of the test laboratory

Bontek Compliance Testing Laboratory Ltd 1/F, Block East H-3, OCT Eastern Ind. Zone, Qiaocheng East Road, Nanshan, Shenzhen, China

The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 (2003) and CISPR Publication 22.

3.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 338263

Bontek Compliance Testing Laboratory Ltd EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 338263, March 24, 2008.

IC Registration No.: 7631A

The 3m alternate test site of Bontek Compliance Testing Laboratory Ltd EMC Laboratory has been registered by Certification and Engineer Bureau of Industry Canada for the performance of with Registration NO.: 7631A on March, 2011.

3.3. Environmental conditions

During the measurement the environmental conditions were within the listed ranges

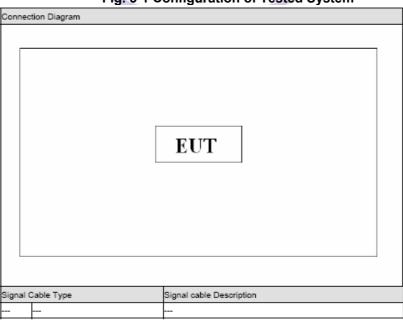
Temperature: 15-35 ° C

Humidity: 30-60 %

Atmospheric pressure: 950-1050mbar

3.4. Configuration of Tested System

Fig. 3-1 Configuration of Tested System



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3.5. Test Description

No deviations from the test standards For BT function:

Performed Test Item	Normative References	Test Performed	Deviation
Equivalent Isotropic Radiated Power	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No
Maximum Spectral Power Density	ETSI EN 300 328 V1.7.1 (2006-10)	N/A	N/A
Frequency Range	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No
Transmitter Spurious Emissions	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No
Receiver Spurious Emissions	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No
Dwell Time	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No
Hopping Channel	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No
Hopping Sequence	ETSI EN 300 328 V1.7.1 (2006-10)	Yes	No

Note: The requirement of **Medium access protocol** has been implemented by manufacturer.

3.6. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements" and is documented in the Bontek Compliance Testing Laboratory Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Bontek laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.10dB	(1)
Radiated Emission	1~12.75GHz	4.32dB	(1)
Conducted Disturbance	0.15~30MHz	3.22dB	(1)

⁽¹⁾ This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.7. Equipments Used during the Test

Frequ	ency Range				
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Receiver	Rohde&Schwarz	ESI 26	100032	2013/04
2	Climate Chamber	ESPEC	EL-10KA	05107008	2013/04

Spurio	ous Emissions				
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	ULTRA-BROADBAND ANTENNA	ROHDE & SCHWARZ	HL562	100045	2013/04
2	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESI 26	100032	2013/04
3	RF TEST PANEL	ROHDE & SCHWARZ	TS / RSP	335021/ 0025	2013/04
4	TURNTABLE	ETS	2088	2151	2013/04
5	ANTENNA MAST	ETS	2075	2387	2013/04
6	HORN ANTENNA	ROHDE &SCHWARZ	HF906	100067	2013/04
6	EMI TEST SOFTWARE	ROHDE & SCHWARZ	ESK1	N/A	2013/04

Equiv	alent isotropically radiate	ed power(EIRP)		h.	
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal.
1	Power Meter	AR	PM2002	304249	2013/04
2	Power Head	AR C	PH2000	302541	2013/04
3	Climate Chamber	ESPEC	EL-10KA	06127003	2013/04
4	RF Cable	V Charles Fr	the IV	13	1
Mark: ∃	The Cal. Due is 1 year.	Flectromag	netic Tech	Solour	

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4. TEST CONDITIONS AND RESULTS

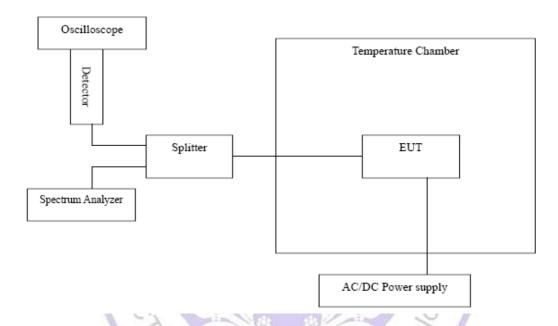
4.1. ETSI EN 300 328 REQUIREMENTS

4.1.1. Equivalent Isotropically Radiated Power LIMIT

According to ETSI EN 300 328 V1.7.1/2006-10 clause 4.3.1.2

Maximum EIR Limit	
-10dBW/(100mW)/20dBm	

TEST CONFIGURATION



TEST PROCEDURE

- 1. Please refer to ETSI EN 300 328 (V1.7.1) clause 5.3 for the test conditions.
- 2. Please refer to ETSI EN 300 328 (V1.7.1) clause 5.7.2.2 for the measurement method.

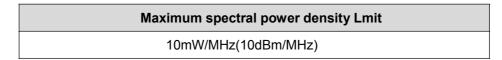
		Measurement me	ethod: EIRP(Ra	diated)
		-	Test Result	
Rel. Humidity: 65 %	6	Measured	EIRP	EIRP Limit
Lowest Frequenc	y: 2402MHz	Power (dBm)	(dBm)	(dBm)
Tnom 25 ℃	Vnom 3.7 Vdc	-1.43	1.57	20
T : 00 %	Vmin 3.145 Vdc	-1.37	1.63	20
Tmin -20 °C	Vmax 4.255 Vdc	-1.40	1.60	20
T	Vmin 3.145 Vdc	-1.35	1.65	20
Tmax 55 ℃	Vmax 4.255 Vdc	-1.41	1.59	20
Middle Frequency	r: 2441MHz			
Tnom 25 ℃	Vnom 3.7 Vdc	-1.37	1.63	20
T : 00 %	Vmin 3.145 Vdc	-1.39	1.61	20
Tmin -20 °C	Vmax 4.255 Vdc	-1.34	1.66	20
- 10	Vmin 3.145 Vdc	-1.36	1.64	20
Tmax 55 ℃	Vmax 4.255 Vdc	-1.38	1.62	20
Highest Frequenc	y: 2480MHz			
Tnom 25 ℃	Vnom 3.7 Vdc	-1.36	1.64	20
T : 00 %	Vmin 3.145 Vdc	-1.37	1.63	20
Tmin -20 °C	Vmax 4.255 Vdc	-1.35	1.65	20
T 55 %	Vmin 3.145 Vdc	-1.39	1.61	20
Tmax 55 °C	Vmax 4.255 Vdc	-1.32	1.68	20
Test Result	9 3	Pass	200	
	Flean	magnetic	Chino	

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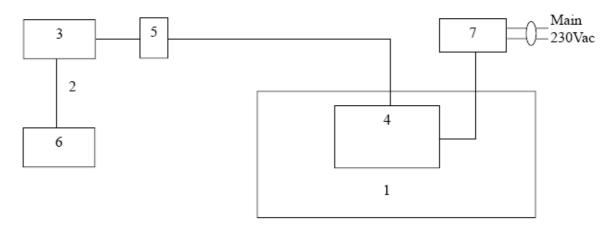
4.1.2. Maximum Spectral Power Density

LIMIT

According to ETSI EN 300 328 V1.7.1/2006-10 clause 4.3.2.2



TEST CONFIGURATION



Legend

- 1. Wooden table
- 2. Test cable
- 3. Spectrum analyzer
- 4. EUT
- 5. DC block
- 6. Power meter
- 7. Power supply

TEST PROCEDURE

- 1. Please refer to ETSI EN 300 328 (V1.7.1) clause 5.3 for the test conditions.
- 2. Please refer to ETSI EN 300 328 (V1.7.1) clause 5.7.3 for the measurement method.

TEST RESULTS

For Bluetooth: It is not suitable to perform this test item as the requirements in this clause are only applicable to equipment using wide band modulations other than FHSS (e.g. DSSS, OFDM, etc.).

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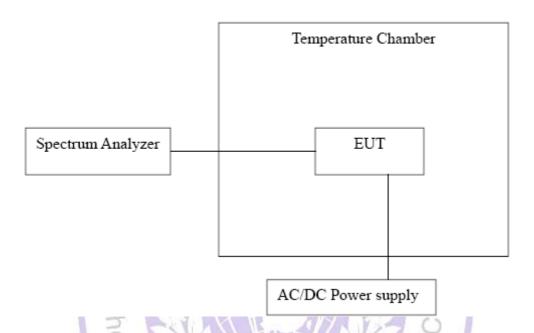
4.1.3. Frequency Range

LIMIT

According to ETSI EN 300 328 V1.7.1/2006-10 clause 4.3.3.2

Frequency range Lmit	
F _{Low} > 2.4G	F _{High} < 2.4835GHz

TEST CONFIGURATION



Pectromagnetic Tech

TEST PROCEDURE

- Please refer to ETSI EN 300 328 (V1.7.1) clause 5.3 for the test conditions.
 Please refer to ETSI EN 300 328 (V1.7.1) clause 5.7.4 for the measurement method.

Bluetooth mode			
		Measurement method: Cor	nducted
		Test R	lesult
Rel. Humidity: 65 9	%		
		Measured Freq.	Limit
Lowest Frequency: 2402MHz		(MHz)	(MHz)
nom 25 ℃	Vnom 3.7 Vdc	2402.6	>2400.0
	Vmin 3.145 Vdc	2402.5	>2400.0
「min -20 ℃	Vmax 4.255 Vdc	2402.4	>2400.0
T F.F. °C	Vmin 3.145 Vdc	2402.2	>2400.0
max 55 °C	Vmax 4.255 Vdc	2402.4	>2400.0
lighest Frequenc	cy: 2480MHz		
「nom 25 ℃	Vnom 3.7 Vdc	2480.9	<2483.5
	Vmin 3.145 Vdc	2480.5	<2483.5
「min -20 ℃	Vmax 4.255 Vdc	2480.7	<2483.5
	Vmin 3.145 Vdc	2480.6	<2483.5
「max 55 ℃	Vmax 4.255 Vdc	2480.7	<2483.5
Test Result	\$ 16	Pass	· p
	enzhen CTLEJech	Omagnetic Technology	1,09y Co.,

4.1.4. Transmitter Spurious Emissions

LIMIT

According to ETSI EN 300 328 V1.7.1/2006-10 clause 4.3.6.2

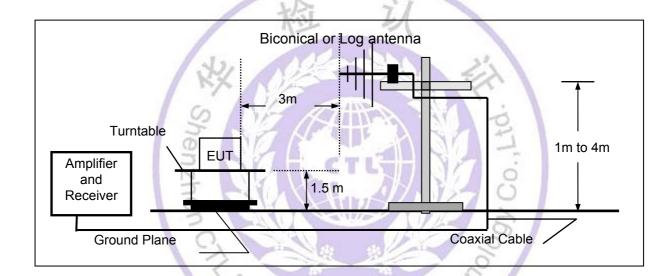
Frequency range	Limit when operating (dBm)	Limit when standby (dBm)
30MHz ~ 1GHz	-36	-57
Above 1GHz ~ 12.75GHz	-30	-47
1.8GHz ~ 1.9GHz 5.15GHz ~ 5.3GHz	-47	-47

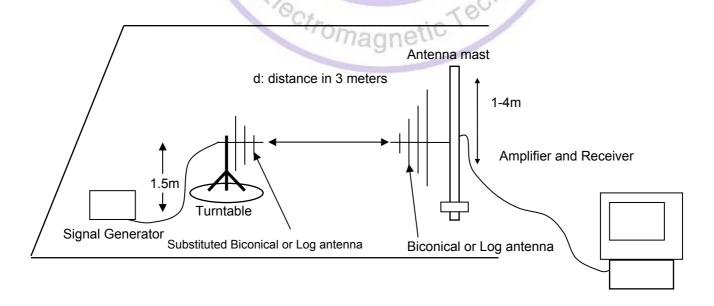
Note: Note: All emissions detected are belong to narrowband emission at here.

TEST CONFIGURATION

Effective Radiated Power measurement (30 MHz to 12.75 GHz)

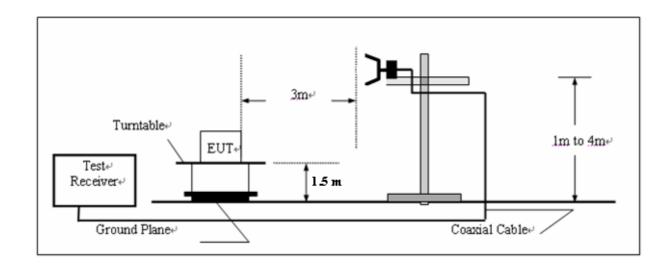
Below 1GHz

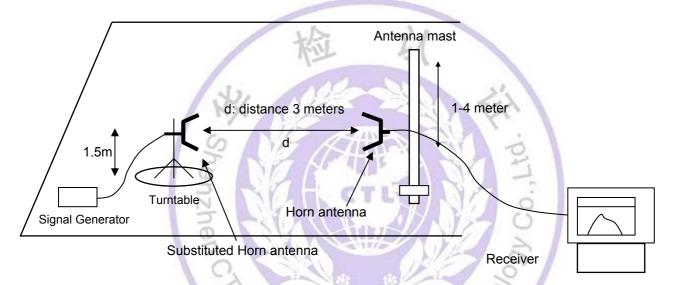




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Above 1GHz





TEST PROCEDURE

- Please refer to ETSI EN 300 328 (V1.7.1) clause 5.3 for the test conditions.
 Please refer to ETSI EN 300 328 (V1.7.1) clause 5.7.5 for the measurement method.

Bluetooth mode:				
		Measurement method:	EIRP(Radiated)	
		Highest power TX mode		
Rel. Humidity: 65 %		Ambient Temp.: 25 ℃		
Lowest Frequency: 24	02MHz	Те	st Result	
Frequency range (MHz)	Res. Bandwidth (kHz)	Maximum Emission Observed (MHz)	Limit (dBm)	Margin (dB)
30 ~ 1000	100	-64.33	-36	30.33
1000 ~ 1800	1000	-60.07	-30	30.07
1800 ~ 1900	1000	-60.94	-47	13.94
1900 ~5150	1000	-61.15	-30	31.15
5150 ~ 5350	1000	-55.56	-47	8.56
5350 ~ 12750	1000	-51.37	-30	21.37
Highest Frequency: 24	480MHz			
30 ~ 1000	100	-65.72	-36	29.72
1000 ~ 1800	1000	-63.29	-30	33.29
1800 ~ 1900	1000	-60.43	-47	13.43
1900 ~5150	1000	-60.24	-30	30.24
5150 ~ 5350	1000	-54.49	-47	7.49
5350 ~ 12750	1000	-50.19	-30	20.19
Test Re	sult	Hone	Pass	
	CARRIECTE	omagnetic Ted	Pologia	

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4.1.5. Receiver Emissions

LIMIT

According to ETSI EN 300 328 V1.7.1/2006-10 clause 4.3.7.2

Frequency range	Limit (dBm)	
30MHz ~ 1GHz	-57	
Above 1GHz ~ 12.75GHz -47		
Note: All emissions detected are belong to narrowband emission at here.		

TEST CONFIGURATION

The same as described in section 4.1.4.

TEST PROCEDURE

- Please refer to ETSI EN 300 328 (V.1.7.1) Sub-clause 5.3 for the test conditions.
 Please refer to ETSI EN 300 328 (V1.7.1) Sub-clause 5.7.6 for the measurement method.

Bluetooth mode:					
/	50	Measurement method:	EIRP(Radiated)		
1 3		Highest power RX mode	1		
Rel. Humidity: 65 %		Ambient Temp.: 25 ℃			
Lowest Frequency: 240	2MHz	Tes	t Result		
Frequency range (MHz)	Res. Bandwidth (kHz)	Maximum Emission Observed (MHz)	Limit (dBm)	Margin (dB)	
30 ~ 1000	100	-68.36	-57	11.36	
1000 ~ 12750	1000	-57.55	-47	10.55	
Highest Frequency: 24	80MHz			·	
30 ~ 1000	100	-66.34	-57	9.34	
1000 ~ 12750	1000	-55.58	-47	8.58	
Test Result		ı	Pass		

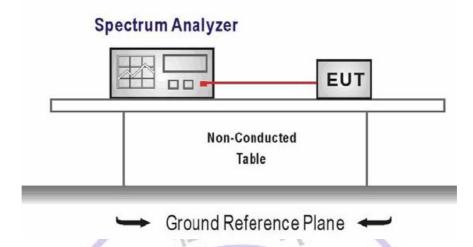
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4.1.6. D well Time

LIMIT

The maximum dwell time shall be 0.4 s.

TEST CONFIGURATION



TEST PROCEDURE

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

Span = zero span, centered on a hopping channel

RBW = 1MHz

 $VBW \, \geqq \, RBW$

Sweep = as necessary to capture the entire dwell time per hopping channel

Detector function = peak

Trace = max hold

If possible, use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation.

	BOTTOM CHANNEL				
Mode	Frequency	Spectrum Reading Test Result		Limit	Dana / Fail
Mode	(MHz)	(uS)	(mS)	(mS)	Pass / Fail
DH1	2402	410	131.2	400	Pass
DH3	2402	1670	267.2	400	Pass
DH5	2402	2920	311.5	400	Pass

MIDDLE CHANNEL					
Modo	Mode Frequency Spectrum Reading Test Result Limit (MHz) (uS) (mS) (mS)		Pass / Fail		
Mode			(mS)	(mS)	FdSS/FdII
DH1	2441	410	131.2	400	Pass
DH3	2441	1660	265.6	400	Pass
DH5	2441	2920	311.5	400	Pass

TOP CHANNEL					
Mode	Frequency	Spectrum Reading	Test Result	Limit	Pass / Fail
Mode	(MHz)	(uS)	(mS)	(mS)	Fass/I all
DH1	2480	410	131.2	400	Pass
DH3	2480	1670	267.2	400	Pass
DH5	2480	2920	311.5	400	Pass

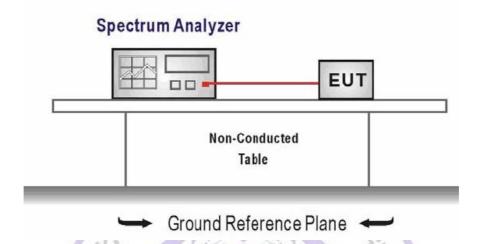
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4.1.7. Hopping Channel

LIMIT

Non-adaptive Frequency Hopping systems shall make use of non-ovelapping hopping channels separated by the channel bandwidth as measured at 20 dB below peak power. The hopping channels defined within a hopping sequence shall be at least 1 MHz apart (channel separation).

TEST CONFIGURATION



TEST PROCEDURE

Use the following spectrum analyzer settings:

Span = approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel

RBW ≥ 1% of the 20dB bandwidth

VBW ≥ RBW

Sweep = auto

Detector function = peak

Trace = max hold

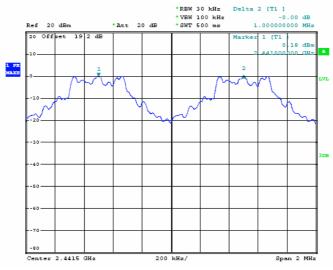
The EUT should be transmitting at its maximum data rate. Allow the trace to stabilize.

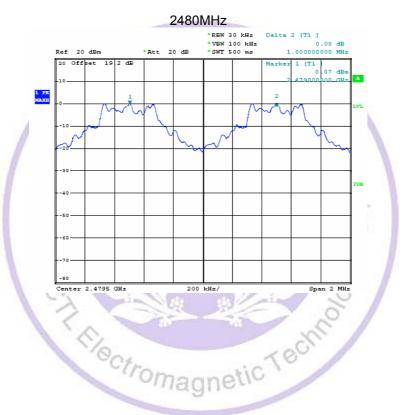
Use the marker-to-peak function to set the marker to the peak of the emission. Use the marker-delta function to measure 20 dB down one side of the emission. Reset the marker-delta function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level. The marker-delta reading at this point is the 20 dB bandwidth of the emission.

Repeat above procedure testing on the adjacent channel, and record all frequencies to determine the nonoverlapping hopping channels and channel separation. If above values varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation.



2441MHz





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4.1.8. Hopping Sequence

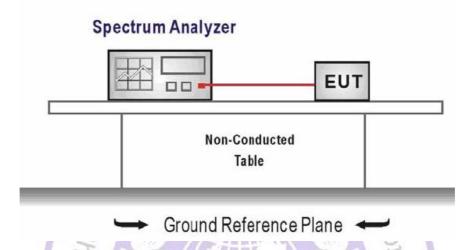
LIMIT

Non-adaptive Frequency Hopping systems shall make use of a hopping sequence(s) that contains at least 15 hopping channels.

Adaptive Frequency Hopping systems shall make use of a hopping sequence(s) that is capable of operating over a minimum of 90% of the band specified in table 1, from which at any give time a minimum of 20 hopping channels shall be used.

Each hopping channel of the hopping sequence shall be occupied at least once during a period not exceeding four times the product of the dwell time per hop and the number of channels.

TEST CONFIGURATION



TEST PROCEDURE

For Hopping Channel Number:

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

Span = the frequency band of operation

RBW ≥ 1% of the span

VBW ≧ RBW Sweep = auto

Detector function = peak

Trace = max hold

Allow the trace to stabilize. It may prove necessary to bread the span up to sections, in order to clearly show all of the hopping frequencies.

For Hopping Sequence:

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

Span = zero span, centered on a hopping channel

RBW = 1MHz

VBW ≥ RBW

Detector function = peak

Sweep mode = Single

Trace = max hold

Hopping Channel Number					
ISM Band	Operating Band	Occupied Band	Limit	Channel	Limit
(MHz)	(MHz)	(%)	(%)	Number	Limit
2400 - 2483.5	2402 - 2480	93.4%	≥90%	79	≥20

Hopping Sequence				
Occupancy Number	Limit	Result		
≥1	≥1	Pass		

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5. Test Setup Photos of the EUT



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6. External and Internal Photos of the EUT





